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FDY101PZ

Single P-Channel (- 2.5V) Specified PowerTrench® MOSFET

General Description

This Single P-Channel MOSFET has been designed using Fairchild Semiconductor's advanced Power Trench process to optimize the $R_{\text{DS}(\text{ON})}$ @ $V_{\text{GS}} = -2.5 v.$

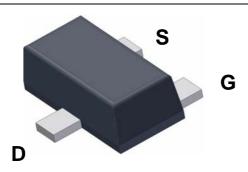
Applications

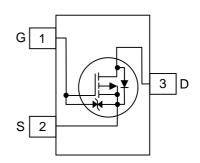
• Li-Ion Battery Pack



Features

- • -150 mA, -20 V R_{DS(ON)} = 8 Ω @ V_{GS} = -4.5 V R_{DS(ON)} = 12 Ω @ V_{GS} = - 2.5 V
- ESD protection diode (note 3)
- · RoHS Compliant





Absolute Maximum Ratings T_A=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V _{DSS}	Drain-Source Voltage		- 20	V
V _{GSS}	Gate-Source Voltage		± 8	V
I _D	Drain Current - Continuous	(Note 1a)	- 150	mA
	– Pulsed		– 1000	
P _D	Power Dissipation (Steady State)	(Note 1a)	625	mW
		(Note 1b)	446	
T_J , T_{STG}	Operating and Storage Junction Temperature Range		-55 to +150	°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (Note 1a)	200	°C/W
Rosa	Thermal Resistance, Junction-to-Ambient (Note 1b)	280	

Package Marking and Ordering Information

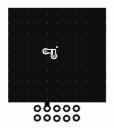
Device Marking		Device	Reel Size	Tape width	Quantity
	В	FDY101PZ	7"	8 mm	3000 units

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics					
BV _{DSS}	Drain–Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \qquad I_{D} = -250 \mu\text{A}$	- 20			V
<u>ΔBV_{DSS}</u> ΔT _J	Breakdown Voltage Temperature Coefficient	$I_D = -250 \mu A$, Referenced to 25°C		15		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = -16 \text{ V}, V_{GS} = 0 \text{ V}$			- 3	μА
I _{GSS}	Gate-Body Leakage,	$V_{GS} = \pm 8 \text{ V}, V_{DS} = 0 \text{ V}$			± 10	μΑ
On Char	acteristics (Note 2)					
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, \qquad I_{D} = -250 \ \mu A$	- 0.65	- 1.0	- 1.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	I_D = 250 μ A, Referenced to 25°C		-3		mV/°C
R _{DS(on)}	Static Drain–Source On–Resistance	$\begin{split} &V_{GS} = -4.5 \text{ V}, I_D = -150 \text{ mA} \\ &V_{GS} = -2.5 \text{ V}, I_D = -125 \text{ mA} \\ &V_{GS} = -1.8 \text{ V}, I_D = -100 \text{ mA} \\ &V_{GS} = -1.5 \text{ V}, I_D = -30 \text{ mA} \\ &V_{GS} = -4.5 \text{ V}, I_D = -150 \text{mA}, \\ &T_{J} = 125^{\circ}\text{C} \end{split}$			8 12 15 20 12	Ω
g _{FS}	Forward Transconductance	$V_{DS} = -5 \text{ V}, I_{D} = -150 \text{ mA}$		0.7		S
Dvnamic	Characteristics					
C _{iss}	Input Capacitance	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V},$		100		pF
Coss	Output Capacitance	f = 1.0 MHz		30		pF
C _{rss}	Reverse Transfer Capacitance			15		pF
Switchin	g Characteristics (Note 2)					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = -10 \text{ V}, I_{D} = -0.5 \text{ A},$		6	12	ns
t _r	Turn-On Rise Time	$V_{GS} = -4.5 \text{ V}, R_{GEN} = 6 \Omega$		13	23	ns
$t_{\text{d(off)}}$	Turn-Off Delay Time			8	16	ns
						no
t _f	Turn–Off Fall Time			1	2	ns
$\frac{t_f}{Q_g}$	Turn–Off Fall Time Total Gate Charge	$V_{DS} = -10 \text{ V}, I_{D} = -150 \text{ mA},$		1.0	1.4	nC
Q_g		$V_{DS} = -10 \text{ V}, I_{D} = -150 \text{ mA}, \ V_{GS} = -4.5 \text{ V}$				
Q_g Q_{gs}	Total Gate Charge			1.0		nC
Q _g Q _{gs} Q _{gd}	Total Gate Charge Gate–Source Charge Gate–Drain Charge	V _{GS} = -4.5 V		1.0		nC nC
Q _g Q _{gs} Q _{gd}	Total Gate Charge Gate–Source Charge	V _{GS} = -4.5 V		1.0		nC nC
Q _g Q _{gs} Q _{gd} Drain–So	Total Gate Charge Gate—Source Charge Gate—Drain Charge Durce Diode Characteristics Drain—Source Diode Forward	V _{GS} = - 4.5 V s and Maximum Ratings		1.0 0.2 0.3	1.4	nC nC

T_A = 25°C unless otherwise noted

Notes

1. R_{aJA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{aJC} is guaranteed by design while R_{aCA} is determined by the user's board design.



Electrical Characteristics

a) 200°C/W when mounted on a 1in² pad of 2 oz copper



- b) 280°C/W when mounted on a minimum pad of 2 oz copper Scale 1 : 1 on letter size paper
- 2. Pulse Test: Pulse Width < $300\mu s$, Duty Cycle < 2.0%
- The diode connected between the gate and source serves only as protection againts ESD. No gate overvoltage rating is implied.

Typical Characteristics

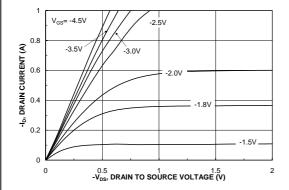


Figure 1. On-Region Characteristics.

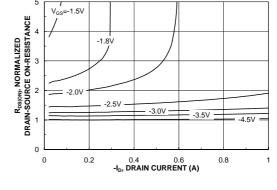
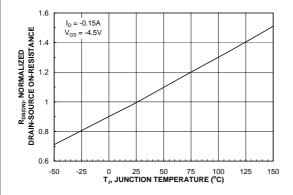


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.



igure 3. On-Resistance Variation with Temperature.

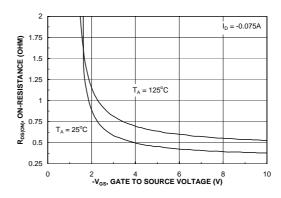


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

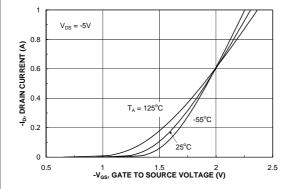


Figure 5. Transfer Characteristics.

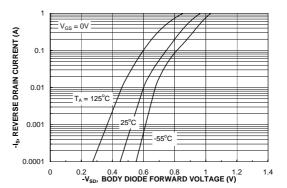


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics

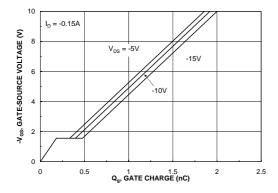


Figure 7. Gate Charge Characteristics.

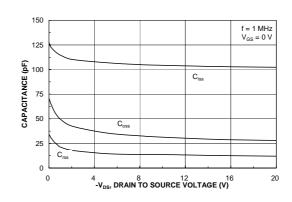


Figure 8. Capacitance Characteristics.

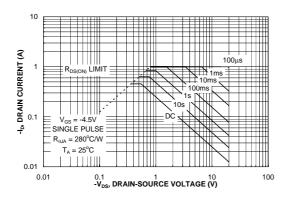


Figure 9. Maximum Safe Operating Area.

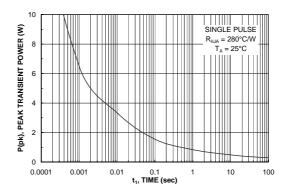


Figure 10. Single Pulse Maximum Power Dissipation.

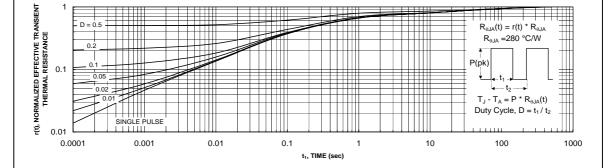
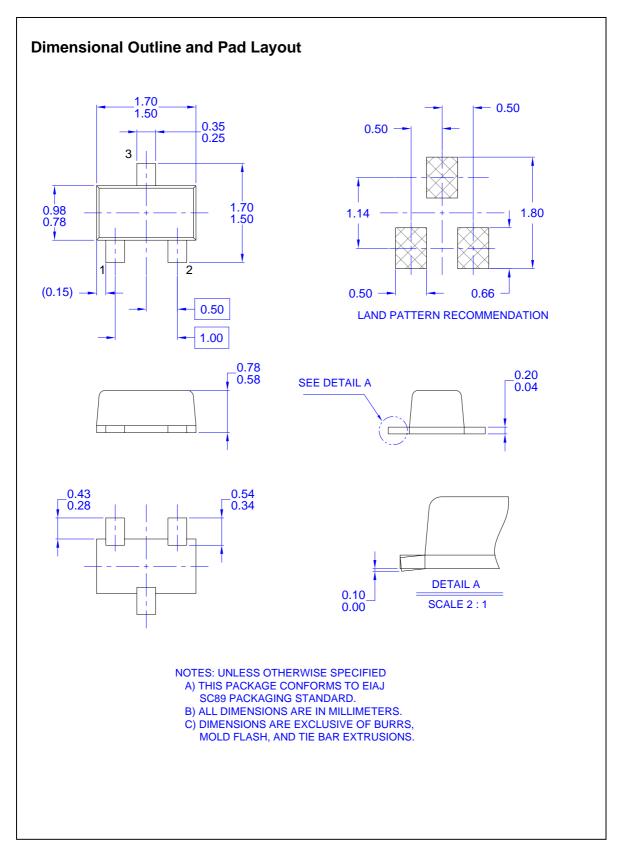


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.



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